## Application/Control No. Applicant(s)/Patent Under Reexamination 10/017,658 DERNER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Tan T. Nguyen 2818 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,545,899 04-2003 Derner et al. 365/94 Α US-US-С D US-E US-F US-G US-US-Η US-1 US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.